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Application/Control No.	Applicant(s)/Par Reexamination
10/090 758	MAIF ET AI

10/090,758 Examiner

Jonathan G. Sterrett

Applicant(s)/Patent under
Reexamination

MAIE ET AL.

Art Unit

3623

SEARCHED			
Class	Subclass	Date	Examiner
705	7-10	6/21/2006	JGS
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
			:

SEARCH N (INCLUDING SEAR))
	DATE	EXMR
East Classification Search	6/21/2006	JGS
East Keyword Search	6/27/2006	JGS
ProQuest	6/28/2006	JGS
Dialog	6/29/2006	JGS